

General Description

The SJD30N026 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a wide variety of applications.

Features

- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

Application

- Load switch
- PWM applications
- Power management

Key Performance Parametes

Parameter	Value	Unit
V _{DS}	30	V
R _{DS(ON)_TYP}	2.8	mΩ
ID	120	А
Q _G	48	nC



Schematic Diagram

TO-252(DPAK) top view

Package Marking and Ordering Information

Device/Ordering Code	Marking	Package	Reel Size	Tape width	Quantity
SJD30N026	SJD30N026	TO-252	١	١	/

Table 1. Absolute Maximum Ratings ($T_c=25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V _{DS}	Drain-Source Voltage (V _{GS} =0V)	30	V
V _{GS}	Gate-Source Voltage (V _{DS} =0V)	±20	V
	Drain Current-Continuous(Tc=25°C)	120	А
lo	Drain Current-Continuous(T _c =100°C)	76	А
DM (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	480	А
P	Maximum Power Dissipation(T _C =25 [°] C)	78	W
PD	Maximum Power Dissipation(Tc=100 $^{\circ}\mathrm{C}$)	31	W
E _{AS}	Avalanche energy (Note 2)	256	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 150	ĉ

Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
Rejc	Thermal Resistance, Junction-to-Case		1.61	°C/W



Table 3. Electrical Characteristics (T_J=25 $^{\circ}$ C unless otherwise noted)

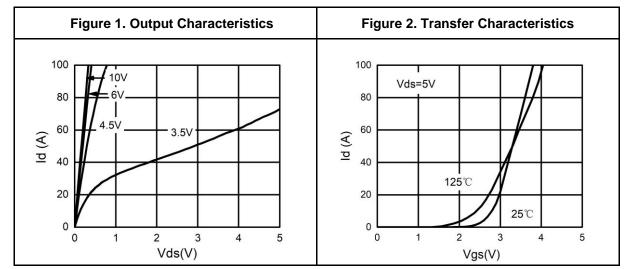
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States	-					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V I _D =250µA	30			V
		V _{DS} =30V, V _{GS} =0V TJ=25℃			1	μA
IDSS	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V T _J =125℃			100	μA
lgss	Gate-Body Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	1.0		2.5	V
g fs	Forward Transconductance	V _{DS} =5V, I _D =20A		28.2		S
5		V _{GS} =10V, I _D =20A T _J =25℃		2.8	3.4	mΩ
R _{DS(ON)}	Drain-Source On-State Resistance	V _{GS} =4.5V, I _D =15A T _J =25℃		4.3	5.7	mΩ
Dynamic Chara	icteristics		L		L	
Ciss	Input Capacitance			2764		pF
Coss	Output Capacitance	V _{DS} =15V,V _{GS} =0V, f=1.0MHz		289		pF
Crss	Reverse Transfer Capacitance			265		pF
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1.0MHz		1.7		Ω
Switching Para	meters			1		
t _{d(on)}	Turn-on Delay Time			14.4		nS
tr	Turn-on Rise Time	V _{GS} =10V, V _{DS} =15V,		36		nS
$t_{d(off)}$	Turn-Off Delay Time	R _L =0.75Ω, R _{GEN} =3Ω		43.6		nS
t _f	Turn-Off Fall Time			22		nS
Qg	Total Gate Charge			48		nC
Q_{gs}	Gate-Source Charge	V _{GS} =10V, V _{DS} =15V, I _D =20A		5.2		nC
Q_gd	Gate-Drain Charge	-		9.6		nC
Source-Drain D	iode Characteristics			•		
I _{SD}	Source-Drain Current (Body Diode)				120	Α
Vsd	Forward on Voltage (Note 3)	V _{GS} =0V, I _S =20A			1.2	V
t _{rr}	Reverse Recovery Time	l⊧=20A, dl/dt=100A/μs		56		ns
Qrr	Reverse Recovery Charge	l⊧=20A, dl/dt=100A/μs		42		nC

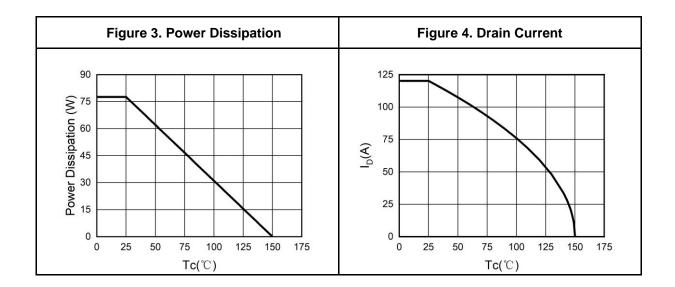
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

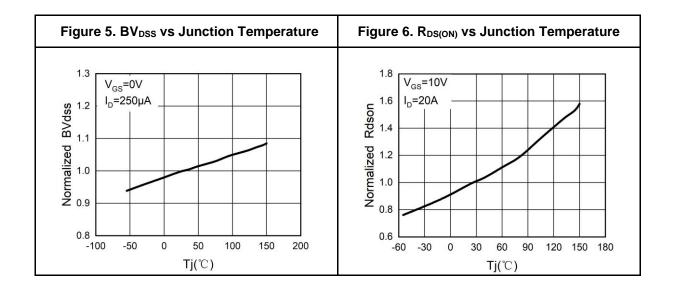
Notes 2.E_{AS} condition: $T_{J=25}^{\circ}$ C,V_{DD}=30V,V_G=10V, Rg=25 Ω , L=0.5mH. Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.



Typical Electrical And Thermal Characteristics (Curves)





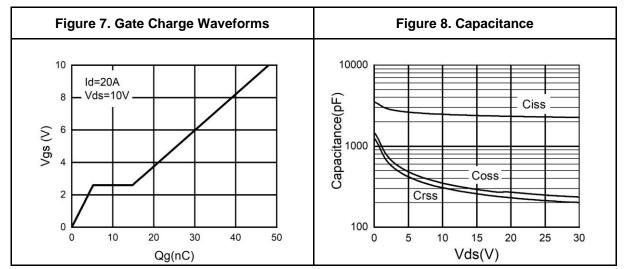


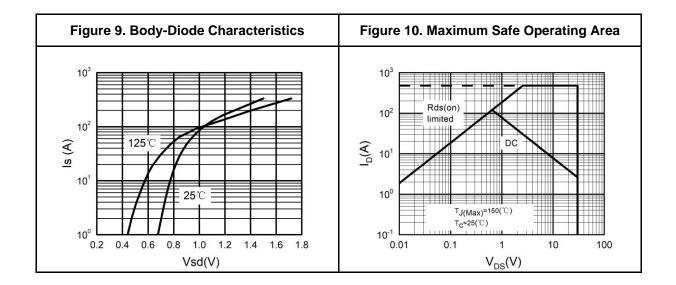


SJD30N026

30V N-Channel Trench Power MOSFET

Typical Electrical And Thermal Characteristics (Curves)

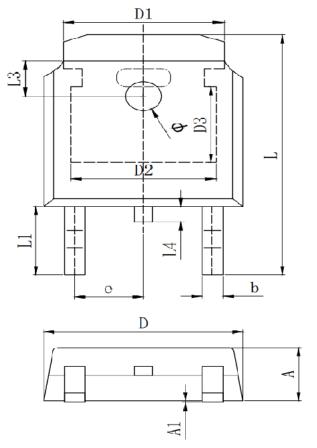


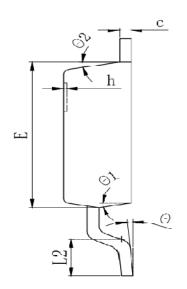






TO-252 Package Information





Symbol	Dimensions In Millimeters			
Symbol	Min.	Тур.	Max.	
А	2.200	2.300	2.400	
A1	0.000		0.127	
b	0.640	0.690	0.740	
c(电镀后)	0.460	0.520	0.580	
D	6.500	6.600	6.700	
D1		5.334 REF		
D2		4.826 REF		
D3	3.166 REF			
E	6.000	6.100	6.200	
е		2.286 TYP		
h	0.000	0.100	0.200	
L	9.900	10.100	10.300	
L1		2.888 REF		
L2	1.400	1.550	1.700	
L3		1.600 REF		
L4	0.600	0.800	1.000	
Φ	1.100	1.200	1.300	
θ	0°		8°	
θ1		9° TYP		
θ2		9° TYP		



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